


<b>Search Notes</b>  	<b>Application/Control No.</b>  10510685	<b>Applicant(s)/Patent Under Reexamination</b>  DUNAS ET AL.
	<b>Examiner</b>  Ho, Huy C	<b>Art Unit</b>  2617

SEARCHED			
Class	Subclass	Date	Examiner
455	3.02	8/14/2007	HH
	427	8/14/2007	HH
	430	8/14/2007	HH
	12.1	8/14/2007	HH
	13.1	8/14/2007	HH
	13.2	8/14/2007	

SEARCH NOTES		
Search Notes	Date	Examiner
EAST image and keyword search in USPATConclusion, US-PGPUB, USOCR, EPO, JPO, DERWENT, IBM_TDB (See attached search strategy)	8/14/2007	HH
Search update	3/31/2008	HH
Search update	9/18/2008	HH

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

/HUY C HO/  
Examiner.Art Unit 2617